



JMSL0615APD

## 60V 12mΩ Dual N-Ch Power MOSFET

### Features

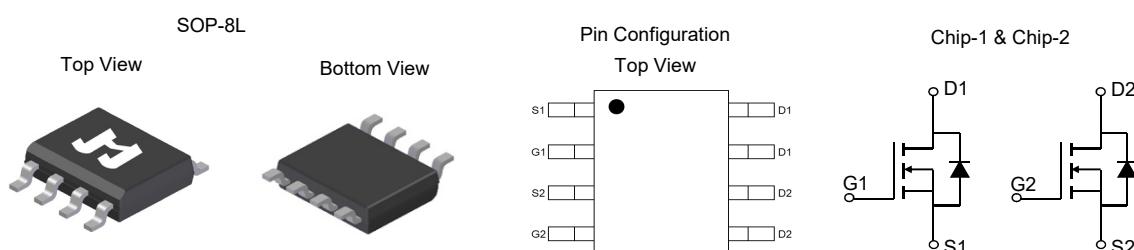
- Low  $R_{DS(ON)}$
- Low Gate Charge
- 100% UIS Tested, 100%  $R_g$  Tested
- Pb-free Lead Plating
- Halogen-free and RoHS-compliant

### Product Summary

Parameter	Value	Unit
$V_{DS}$	60	V
$V_{GS(th)}_{Typ}$	1.7	V
$I_D (@ V_{GS} = 10V)$ <sup>(1)</sup>	9.7	A
$R_{DS(ON)}_{Typ} (@ V_{GS} = 10V)$	12	mΩ
$R_{DS(ON)}_{Typ} (@ V_{GS} = 4.5V)$	15	mΩ

### Applications

- Power Management in Computing, CE, IE 4.0, Communications
- Current Switching in DC/DC & AC/DC (SR) Sub-systems
- Load Switching, Quick/Wireless Charging, Motor Driving

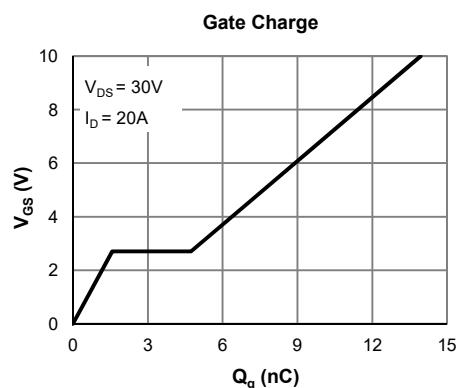
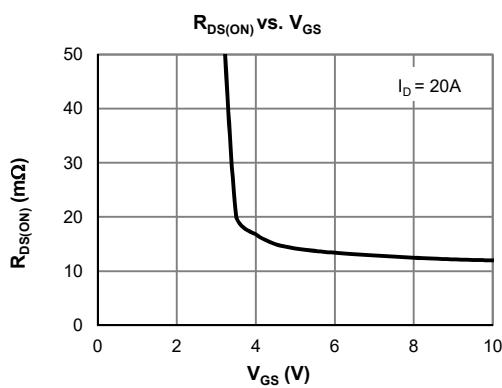


### Ordering Information

Device	Package	# of Pins	Marking	MSL	$T_J$ (°C)	Media	Quantity (pcs)
JMSL0615APD-13	SOP-8L	8	SL0615AD	3	-55 to 150	13-inch Reel	2500

### Absolute Maximum Ratings (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DS}$	60	V
Gate-to-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>(1)</sup>	$I_D$	9.7	A
$T_A = 70^\circ\text{C}$		7.8	
Pulsed Drain Current <sup>(2)</sup>	$I_{DM}$	39	A
Avalanche Current <sup>(3)</sup>	$I_{AS}$	20	A
Avalanche Energy <sup>(3)</sup>	$E_{AS}$	20	mJ
Power Dissipation <sup>(4)</sup>	$P_D$	2.5	W
$T_A = 70^\circ\text{C}$		1.6	
Junction & Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C



**Electrical Characteristics (@  $T_J = 25^\circ\text{C}$  unless otherwise specified)**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>STATIC PARAMETERS</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	60			V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{DS} = 48\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			1.0	$\mu\text{A}$
					5.0	
Gate-Body Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.7	2.5	V
Static Drain-Source ON-Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 9\text{A}$		12	15	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 6\text{A}$		15	20	$\text{m}\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = 5\text{V}, I_D = 9\text{A}$		81		S
Diode Forward Voltage	$V_{SD}$	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.72	1.0	V
Diode Continuous Current	$I_S$	$T_C = 25^\circ\text{C}$			2.5	A
<b>DYNAMIC PARAMETERS<sup>(5)</sup></b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{V}, V_{DS} = 30\text{V}, f = 1\text{MHz}$		731		pF
Output Capacitance	$C_{oss}$			224		pF
Reverse Transfer Capacitance	$C_{rss}$			7.4		pF
Gate Resistance	$R_g$	$V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$		1.7		$\Omega$
<b>SWITCHING PARAMETERS<sup>(5)</sup></b>						
Total Gate Charge (@ $V_{GS} = 10\text{V}$ )	$Q_g$	$V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 30\text{V}, I_D = 9\text{A}$		13.9		nC
Total Gate Charge (@ $V_{GS} = 4.5\text{V}$ )	$Q_g$			7.0		nC
Gate Source Charge	$Q_{gs}$			1.6		nC
Gate Drain Charge	$Q_{gd}$			3.1		nC
Turn-On DelayTime	$t_{D(\text{on})}$	$V_{GS} = 10\text{V}, V_{DS} = 30\text{V}$ $R_L = 3.3\Omega, R_{\text{GEN}} = 6\Omega$		3.7		ns
Turn-On Rise Time	$t_r$			4.3		ns
Turn-Off DelayTime	$t_{D(\text{off})}$			16.2		ns
Turn-Off Fall Time	$t_f$			6.5		ns
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 9\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		24		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$I_F = 9\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		9.3		nC

**Thermal Performance**

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Ambient ( $t \leq 10\text{s}$ )	$R_{\theta JA}$	40	50	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient (steady state)	$R_{\theta JA}$	70	85	$^\circ\text{C/W}$

**Notes:**

1. Computed continuous current assumes the condition of  $T_{J_{\text{Max}}}$  while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under  $T_{J_{\text{Max}}} = 150^\circ\text{C}$ .
3. This single-pulse measurement was taken under the following condition [ $L = 100\mu\text{H}, V_{GS} = 10\text{V}, V_{DS} = 30\text{V}$ ] while its value is limited by  $T_{J_{\text{Max}}} = 150^\circ\text{C}$ .
4. The power dissipation  $P_D$  is based on  $T_{J_{\text{Max}}} = 150^\circ\text{C}$ .
5. This value is guaranteed by design hence it is not included in the production test.

### Typical Electrical & Thermal Characteristics

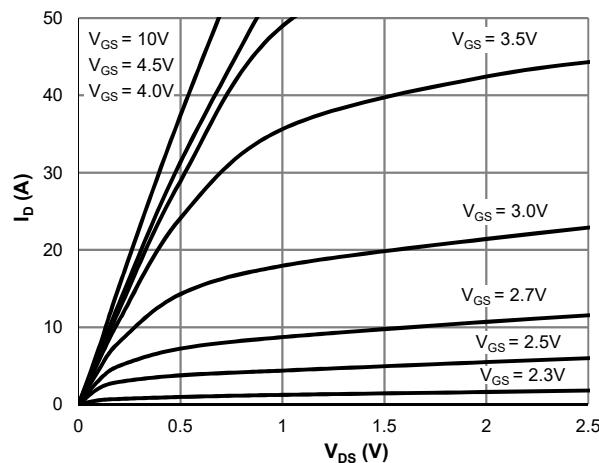


Figure 1: Saturation Characteristics

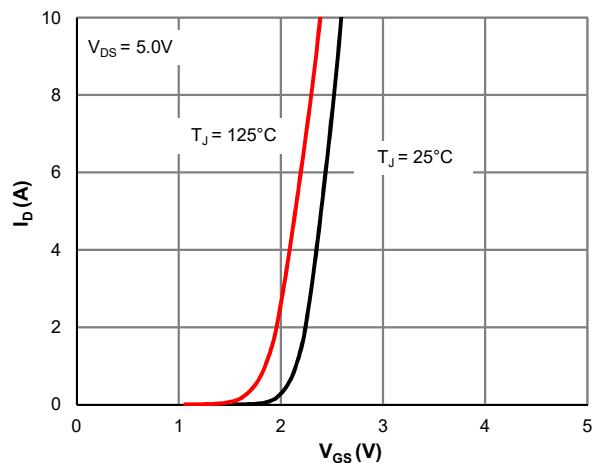


Figure 2: Transfer Characteristics

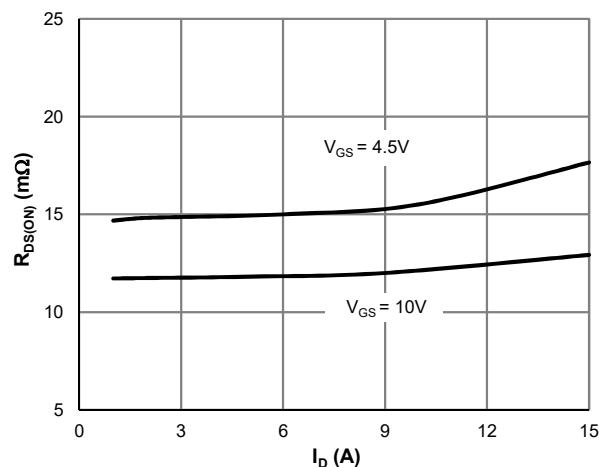


Figure 3:  $R_{DS(ON)}$  vs. Drain Current

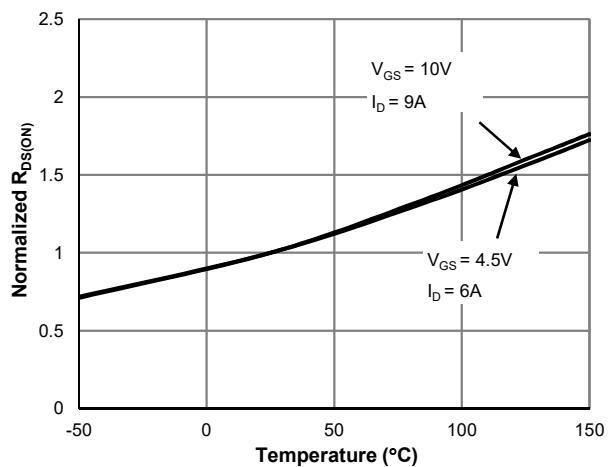


Figure 4:  $R_{DS(ON)}$  vs. Junction Temperature

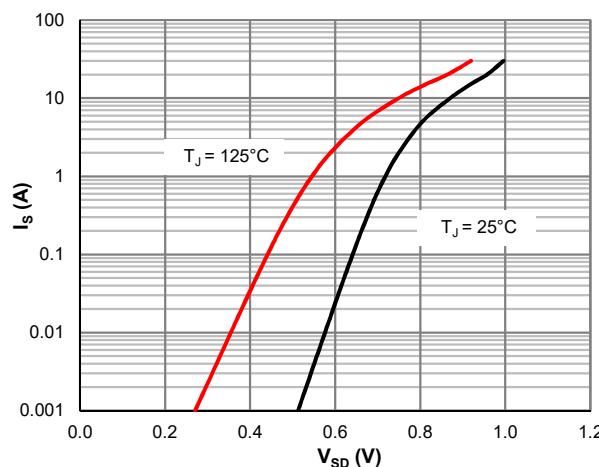


Figure 5: Body-Diode Characteristics

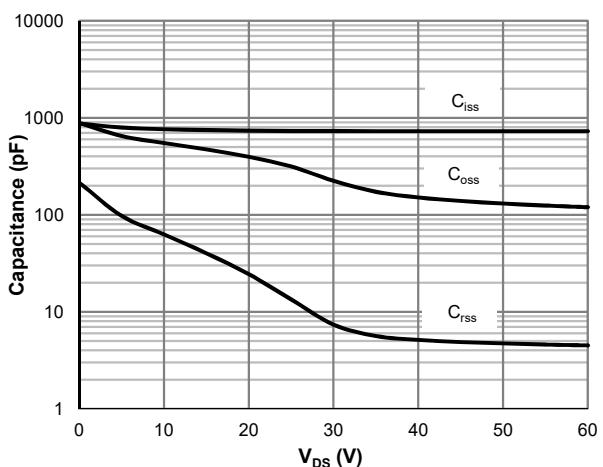


Figure 6: Capacitance Characteristics

### Typical Electrical & Thermal Characteristics

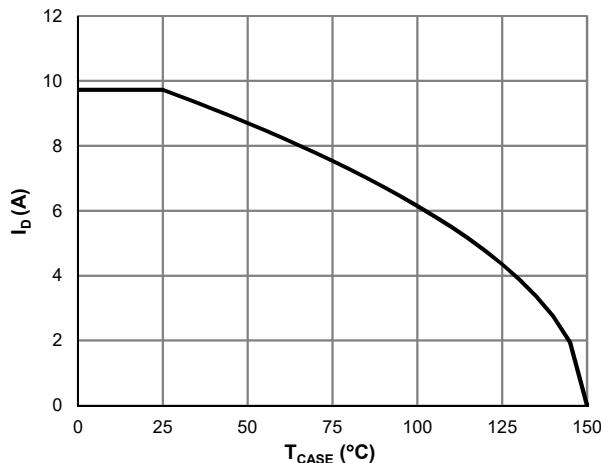


Figure 7: Current De-rating

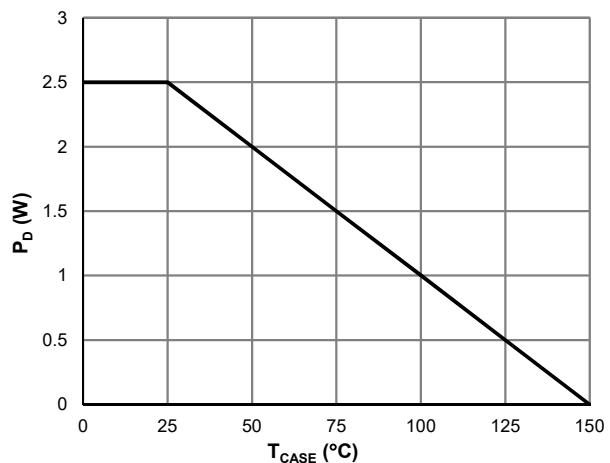


Figure 8: Power De-rating

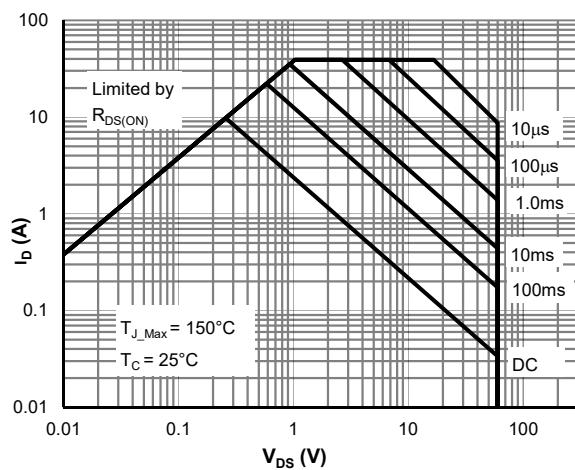


Figure 9: Maximum Safe Operating Area

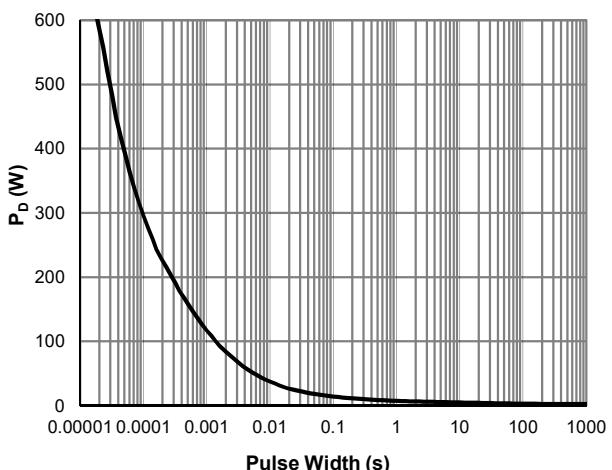


Figure 10: Single Pulse Power Rating, Junction-to-Case

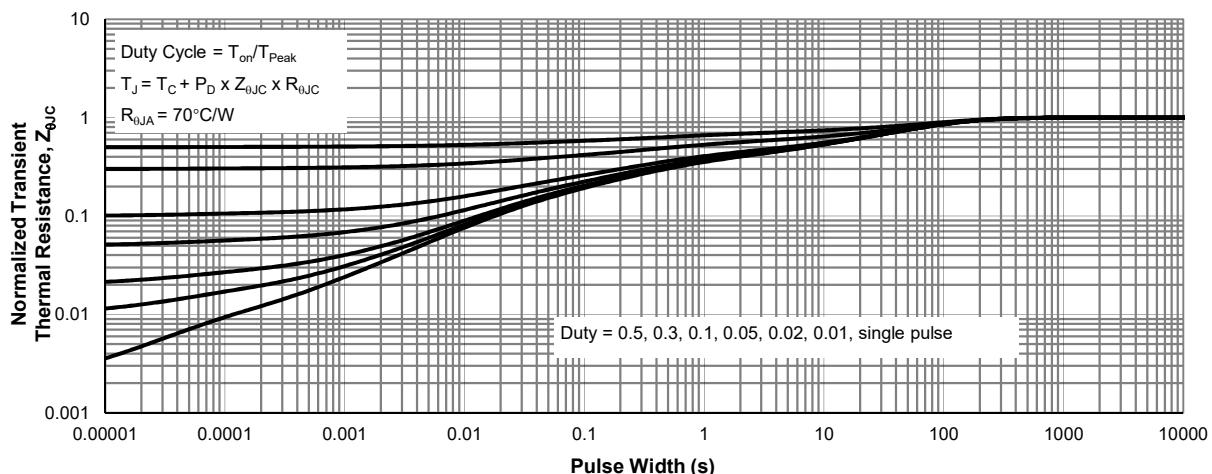
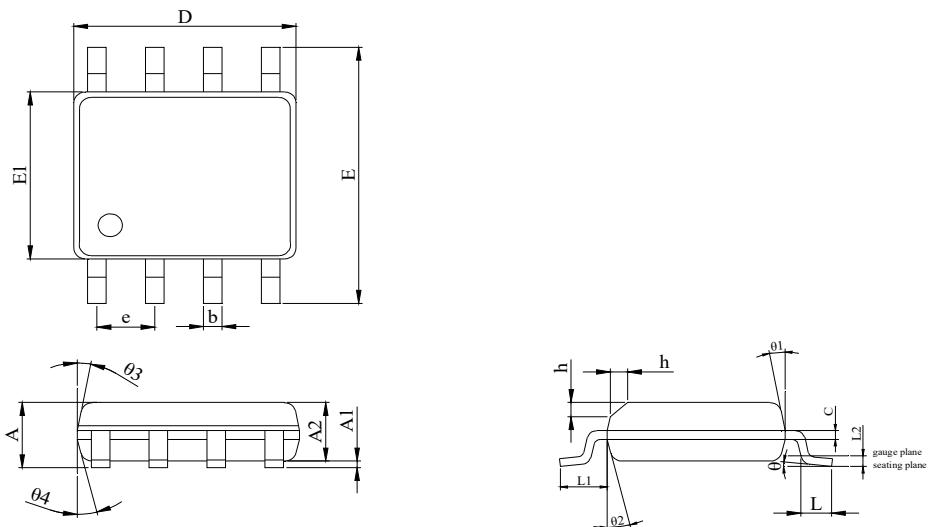


Figure 11: Normalized Maximum Transient Thermal Impedance

### SOP-8L Package Information

#### Package Outline



DIM	MILLIMETER		
	MIN.	NOM.	MAX.
A	1.35	1.50	1.65
A1	0.05	0.10	0.15
A2	1.35	1.40	1.50
b	0.38	--	0.50
c	0.17	--	0.25
D	4.80	4.90	5.00
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
e	1.27(BSC)		
L	0.45	0.60	0.80
L1	1.04 REF		
L2	0.25 BSC		
h	0.30	0.40	0.50
θ	0°	--	8°
θ1	10°	12°	14°
θ2	8°	10°	12°
θ3	10°	12°	14°
θ4	8°	10°	12°

#### Recommended Soldering Footprint

